Notice of References Cited

	Application/Control No.		Applicant(s)/Patent Under Reexamination		
	09/541,552	ZIVITZ, M			
	Examiner	Art Unit			
	Arlen Soderguist	1743	Page 1 of 1		

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	Α	US-4589970	05-1986	Ligtenberg et al.	204/406
	В	US-6340428	01-2002	Ikeda et al.	205/777.5
	C.	US-			
	D	US-			
	Ε	US-			
	F	US-			
	G	US-			
	н	US-			
	ı	US-			
	J	US-			
	К	US-			
	Ļ	US-			
	М	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	Ν,	54-119989	09-1979	JP	Shindo et al.	
	0 ~	89/02593	03-1989	wo	Harman	
	Р.	93/09433	05-1993	wo	Gharib	
1	a'	5-203608	08-1993	JP	Kishimoto et al.	
	R ~	9-201337	08-1997	JP	Minami	
Ì	s					
	Т					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U 、	O. I. Matveev J. Anal. Chem. 1989, 44, 298-299.
	, V	E. S. Boltz et al, Rev. Prog. Quant. Nondestruct. Eval. 1998, 17A, 1043-1049.
	w	W. K. Ward et al, ASAIO J. 2000, 46, 540-546.
	х	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)

Dates in MM-YYYYY format are publication dates. Classifications may be US or foreign.